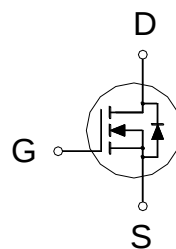


PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
20V	25m Ω	5.3A

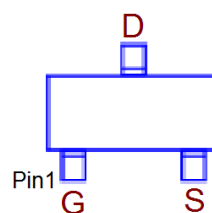


Features

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.



G. GATE
D. DRAIN
S. SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	± 12	V
Continuous Drain Current	$T_A = 25\text{ }^{\circ}\text{C}$	I_D	5.3	A
	$T_A = 70\text{ }^{\circ}\text{C}$		4.3	
Pulsed Drain Current ¹		I_{DM}	18	
Power Dissipation ³	$T_A = 25\text{ }^{\circ}\text{C}$	P_D	1.25	W
	$T_A = 70\text{ }^{\circ}\text{C}$		0.8	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10\text{ s}$	$R_{\theta JA}$		100	$^{\circ}\text{C} / \text{W}$
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		128	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$.

³The Power dissipation is based on $R_{\theta JA}$ $t \leq 10\text{ s}$ value.

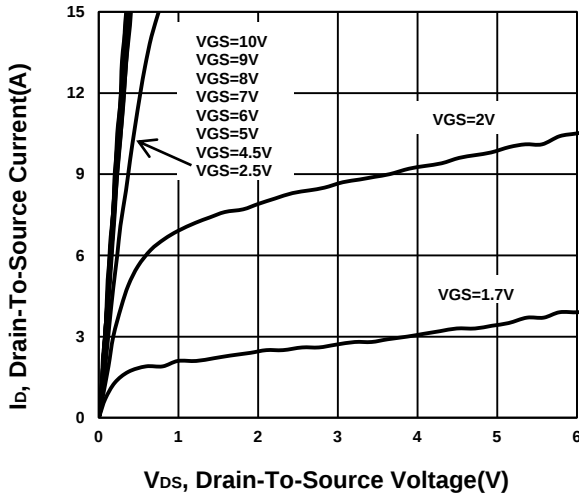
ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	20			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.45	1	1.2	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 12V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 16V, V_{GS} = 0V$			1	μA
		$V_{DS} = 10V, V_{GS} = 0V, T_J = 55\text{ }^\circ C$			10	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = 2.5V, I_D = 4A$		35	50	m Ω
		$V_{GS} = 4.5V, I_D = 5A$		23	32	
		$V_{GS} = 10V, I_D = 5A$		20	25	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 5A$		22.5		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$		389		pF
Output Capacitance	C_{oss}			79		
Reverse Transfer Capacitance	C_{rss}			66		
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		1.7		Ω
Total Gate Charge ²	$Q_{g(VGS=10V)}$	$V_{DS} = 10V, I_D = 5A$		10		nC
	$Q_{g(VGS=4.5V)}$			5.3		
Gate-Source Charge ²	Q_{gs}			0.5		
Gate-Drain Charge ²	Q_{gd}			2.2		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DS} = 10V$ $I_D \cong 5A, V_{GS} = 10V, R_{GS} = 6\Omega$		7.3		nS
Rise Time ²	t_r			40		
Turn-Off Delay Time ²	$t_{d(off)}$			23		
Fall Time ²	t_f			4.7		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25\text{ }^\circ C$)						
Continuous Current	I_S				0.8	A
Forward Voltage ¹	V_{SD}	$I_F = 5A, V_{GS} = 0V$			1.3	V
Reverse Recovery Time	t_{rr}	$I_F = 5A, dI/dt = 100\text{ A}/\mu s$		7.6		nS
Reverse Recovery Charge	Q_{rr}			2.3		nC

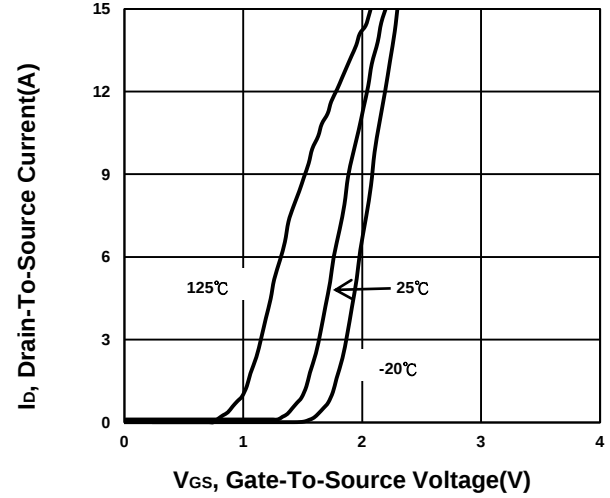
¹Pulse test : Pulse Width $\leq 300\text{ }\mu s$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

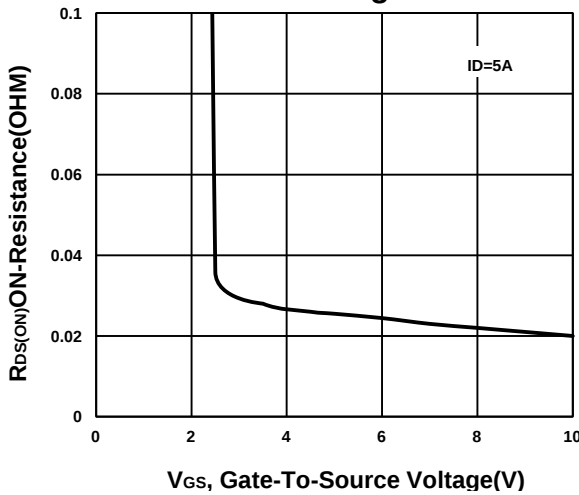
Output Characteristics



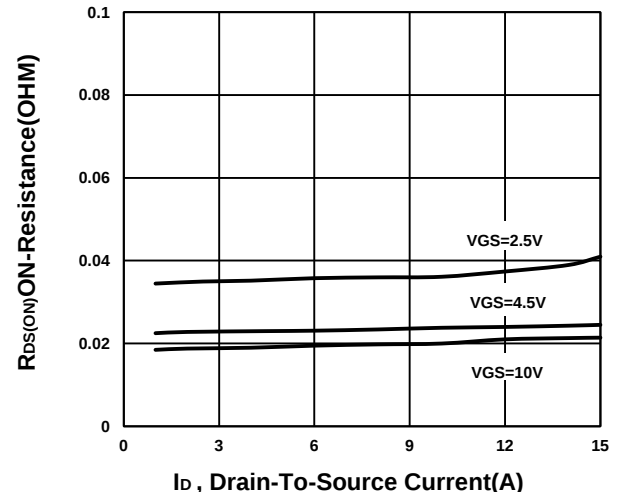
Transfer Characteristics



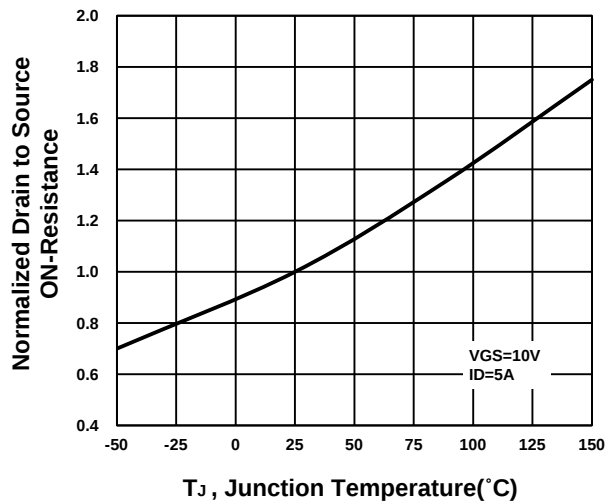
On-Resistance VS Gate-To-Source Voltage



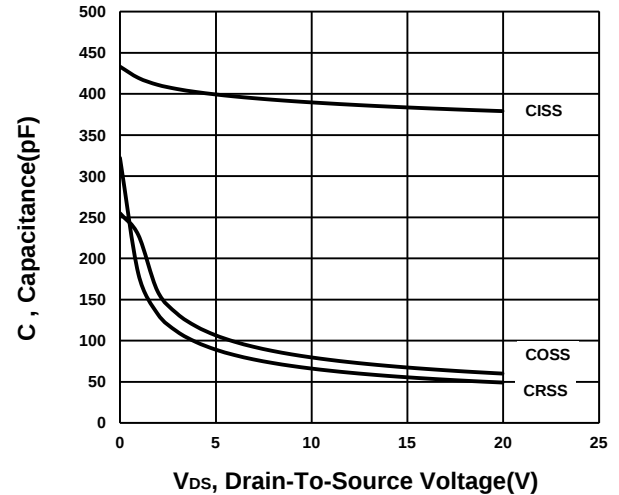
On-Resistance VS Drain Current



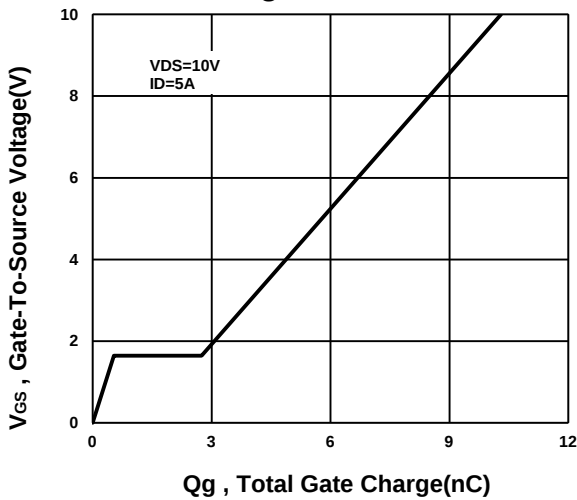
On-Resistance VS Temperature



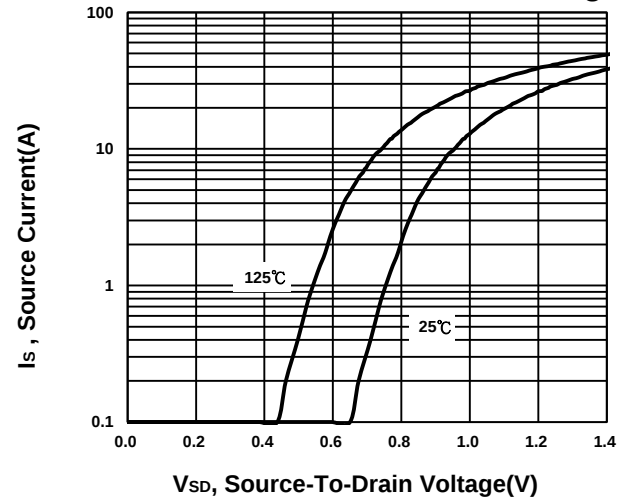
Capacitance Characteristic



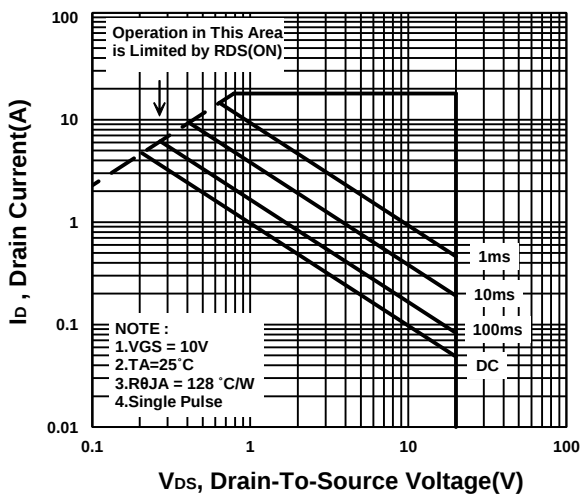
Gate charge Characteristics



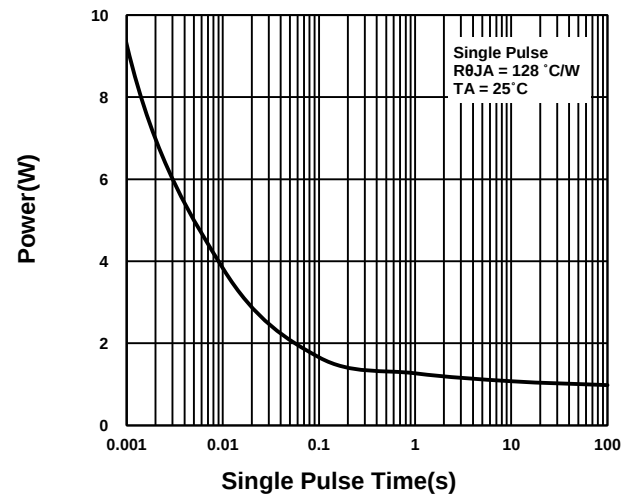
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

